N-Channel Power MOSFET 100 V, 23 A, 56 m Ω , Logic Level

Features

- Low R_{DS(on)}
- 100% Avalanche Tested
- AEC-Q101 Qualified
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	100	V
Gate-to-Source Voltage - Continuous			V _{GS}	± 20	V
Continuous Drain	Steady State $T_C = 25^{\circ}C$ $T_C = 100^{\circ}C$	T _C = 25°C	I _D	23	Α
Current		T _C = 100°C		16	
Power Dissipation	Steady State	T _C = 25°C	P _D	83	W
Pulsed Drain Current	t _p = 10 μs		I _{DM}	80	Α
Operating and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	23	Α
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 50 Vdc, V_{GS} = 10 Vdc, $I_{L(pk)}$ = 23 A, L = 0.3 mH, R_G = 25 Ω)			E _{AS}	79	mJ
Lead Temperature for Soldering Purposes, 1/8" from Case for 10 Seconds			TL	260	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain) - Steady State	$R_{\theta JC}$	1.8	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	39	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1

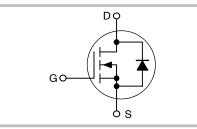
1. Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [2 oz] including traces).



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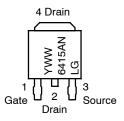
V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
100 V	56 mΩ @ 4.5 V	23 A	
	52 mΩ @ 10 V	20 A	





DPAK CASE 369AA STYLE 2

MARKING DIAGRAM **& PIN ASSIGNMENT**



6415ANL = Device Code

Υ = Year ww = Work Week = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS			•				
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}, T_J = -40^{\circ}\text{C}$		100 92			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$				115		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V},$ $T_{J} = 25^{\circ}\text{C}$				1.0	μΑ
		V _{DS} = 100 V	$T_J = 125^{\circ}C$			100	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	250 μΑ	1.0		2.0	V
Negative Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$				4.8		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D$	= 10 A		44	56	mΩ
		V _{GS} = 10 V, I _D = 10 A			43	52	1
Forward Transconductance	9FS	V _{DS} = 5.0 V, I _D = 10 A			24		S
CHARGES, CAPACITANCES AND GAT	E RESISTANO	CE					
Input Capacitance	C _{ISS}				1024		pF
Output Capacitance	Coss	V _{GS} = 0 V, f = 1.0 MH	z, V _{DS} = 25 V		156]
Reverse Transfer Capacitance	C _{RSS}	1 [70		<u></u>
Total Gate Charge	Q _{G(TOT)}				20		nC
Threshold Gate Charge	Q _{G(TH)}	1.,			1.1		
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 80$	J V, ID = 23 A		3.1		
Gate-to-Drain Charge	Q_{GD}				14		7
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 80 V, I _D = 23 A			35		nC
SWITCHING CHARACTERISTICS (Not	∋ 3)						
Turn-On Delay Time	t _{d(on)}				11		ns
Rise Time	t _r	V _{GS} = 4.5 V, V _{DE}	₀ = 80 V,		91		
Turn-Off Delay Time	t _{d(off)}	I_D = 23 A, R_G = 6.1 $Ω$			40		
Fall Time	t _f				71		
DRAIN-SOURCE DIODE CHARACTER	ISTICS						
Forward Diode Voltage	V_{SD}	V 0.V.I. 00.A	T _J = 25°C		0.87	1.2	V
		$V_{GS} = 0 \text{ V}, I_{S} = 23 \text{ A}$	T _J = 125°C		0.74		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 23 \text{ A}$			64		ns
Charge Time	T _a				40		
Discharge Time	T _b				24		
Reverse Recovery Charge	Q _{RR}				152		nC

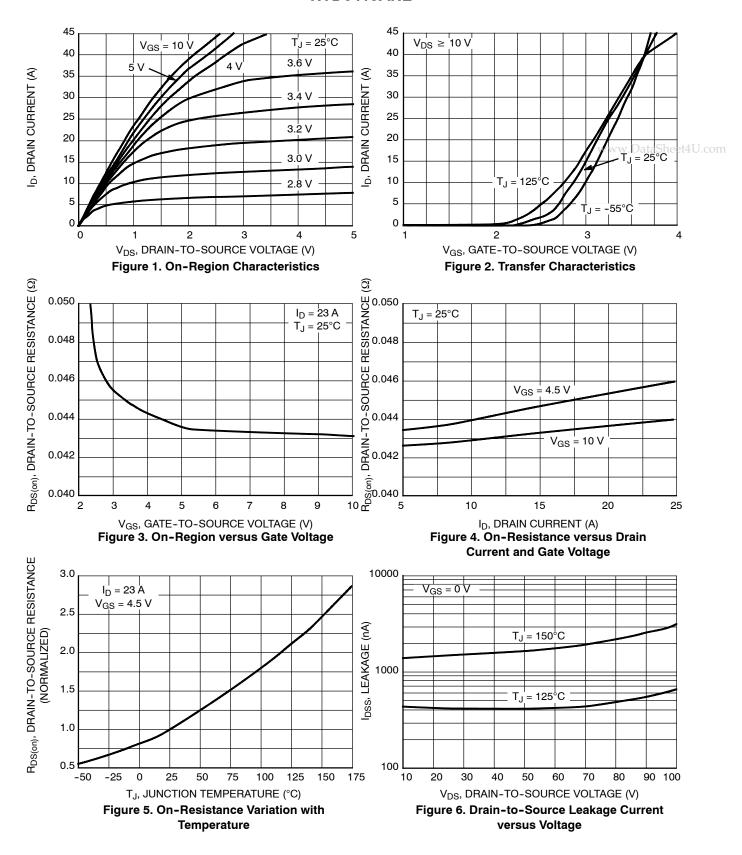
^{2.} Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

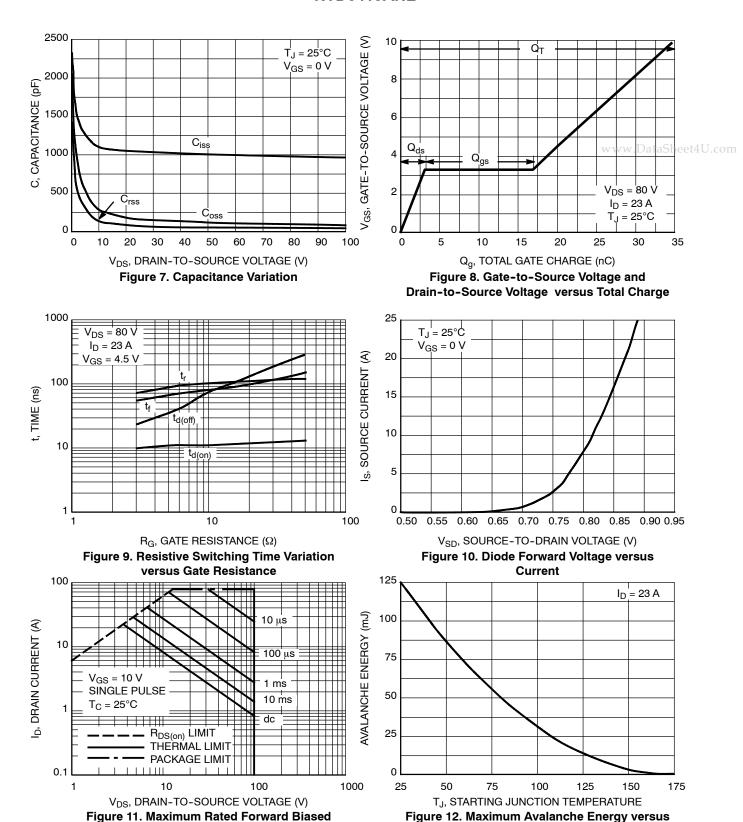
ORDERING INFORMATION

Device	Package	Shipping [†]
NTD6415ANLT4G	DPAK (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

^{3.} Switching characteristics are independent of operating junction temperatures.





Safe Operating Area

Starting Junction Temperature

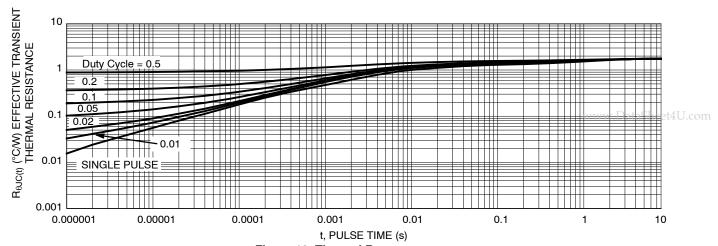
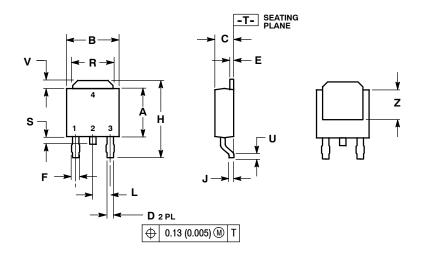


Figure 13. Thermal Response

PACKAGE DIMENSIONS

DPAK (SINGLE GUAGE)

CASE 369AA-01 **ISSUE A**



NOTES:

- DIMENSIONING AND TOLERANCING At Sheet 4U.com
 PER ANSI Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: INCH.

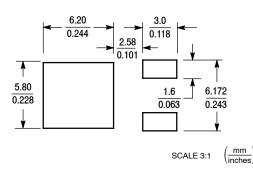
	INCHES		MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.025	0.035	0.63	0.89
Е	0.018	0.024	0.46	0.61
F	0.030	0.045	0.77	1.14
Н	0.386	0.410	9.80	10.40
J	0.018	0.023	0.46	0.58
L	0.090	0.090 BSC		BSC
R	0.180	0.215	4.57	5.45
S	0.024	0.040	0.60	1.01
U	0.020		0.51	
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2:

PIN 1. GATE

- 2. DRAIN 3. SOURCE

SOLDERING FOOTPRINT*



^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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